


<b>Search Notes</b>  	<b>Application/Control No.</b>  10780774	<b>Applicant(s)/Patent Under Reexamination</b>  SHIRAKAWA ET AL.
	<b>Examiner</b>  TU M NGUYEN	<b>Art Unit</b>  3748

SEARCHED			
Class	Subclass	Date	Examiner
60	274, 276, 277, 285, 301	6/2006	TMN
701	103, 109	6/2006	TMN
update search of all above		3/2007	TMN
update search of all above		12/2008	TMN

SEARCH NOTES		
Search Notes	Date	Examiner
EAST search	6/2006	TMN
update EAST search	3/2007	TMN
update EAST search	12/2008	TMN

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
search of all above		12/7/2008	TMN

--	--